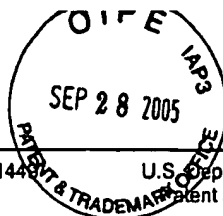


Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-063001	Application No. 09/919,832
	Applicant Shunpei Yamazaki et al.		
	Filing Date August 2, 2001	Group Art Unit 2674	

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